



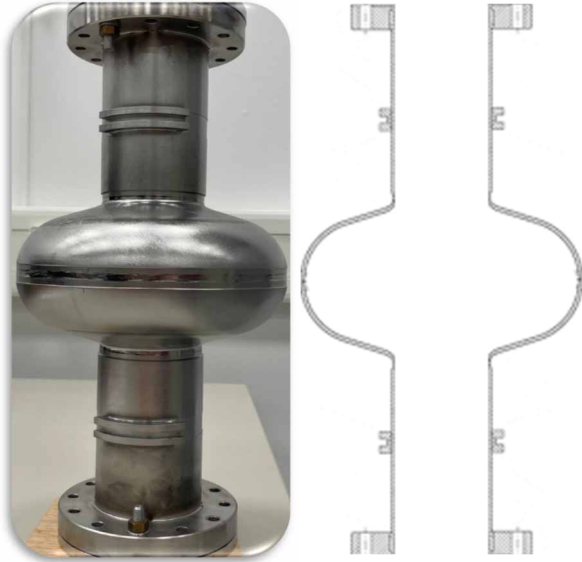
Successful SIS multilayer activities on cavities and samples using ALD

Isabel González Díaz-Palacio on behalf on SRF R&D team

igonzale@physnet.uni-hamburg.de

Pushing SRF cavities performance beyond Nb limits

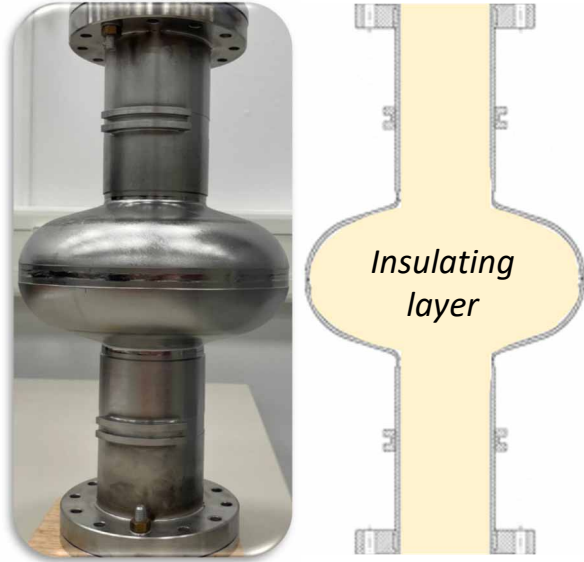
Depositing thin-film **superconductor-insulator-superconductor (SIS)** multilayers on the inner surface of a SRF cavity



Single-cell 1.3 GHz SRF cavity

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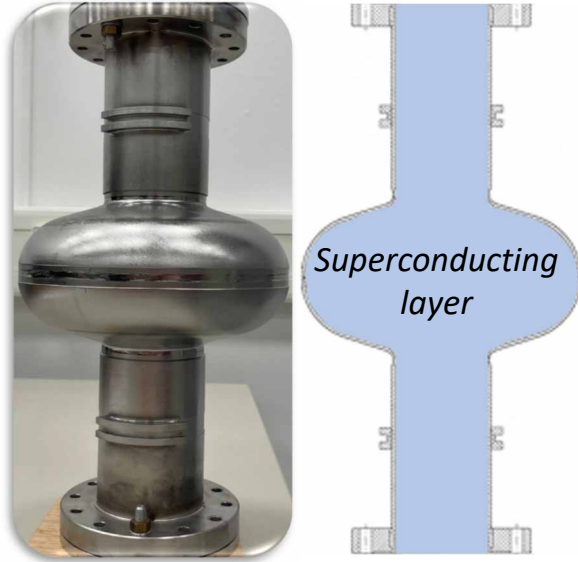
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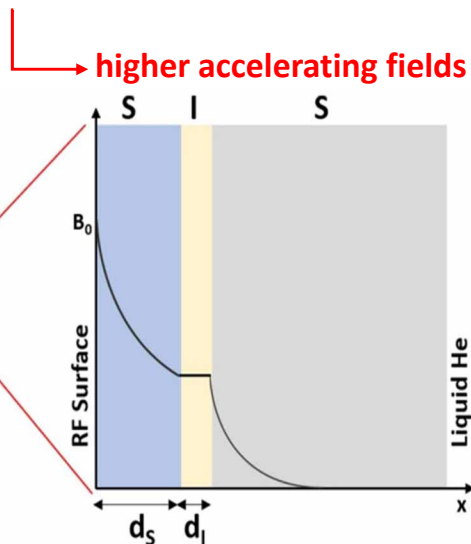
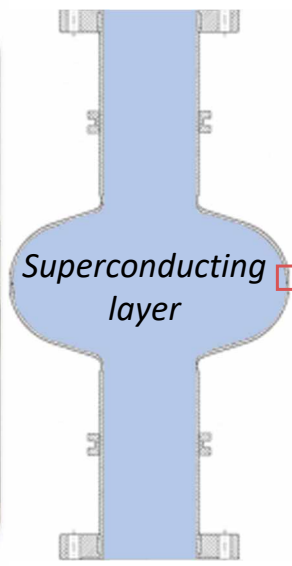
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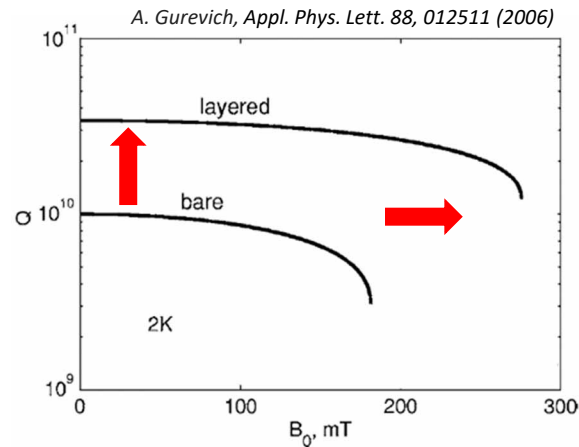
Depositing thin-film **superconductor-insulator-superconductor (SIS)** multilayers on the inner surface of a SRF cavity



Single-cell 1.3 GHz SRF cavity



higher quality factors →



Material candidates for SIS

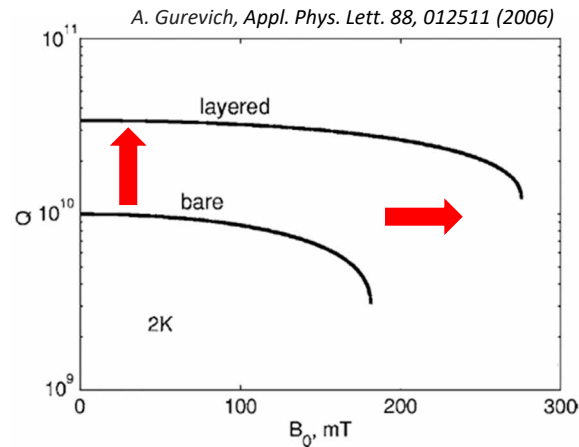
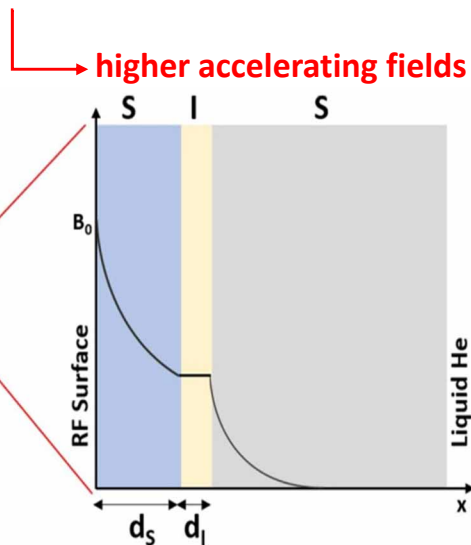
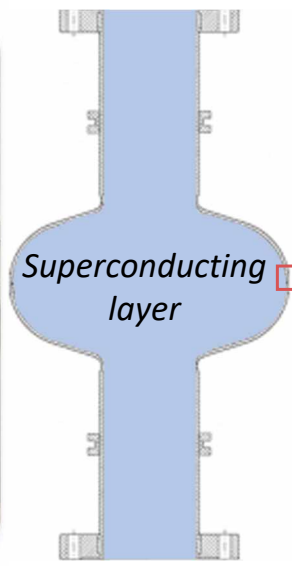
- S: NbN, NbTiN, Nb₃Sn, V₃Si, MoN, ...
- I: AlN, Al₂O₃, Nb₂O₅, MgO, ...

Pushing SRF cavities performance beyond Nb limits

Depositing thin-film superconductor-insulator-superconductor (SIS) multilayers on the inner surface of a SRF cavity



Single-cell 1.3 GHz SRF cavity



Material candidates for SIS

- S: NbN, NbTiN, Nb₃Sn, V₃Si, MoN, ...
- I: AlN, Al₂O₃, Nb₂O₅, MgO, ...

How is the inner surface of the cavity coated?

- Atomic layer deposition (ALD)

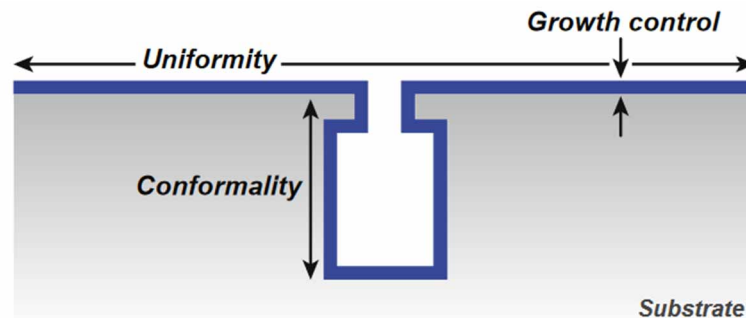
Why ALD is an ideal deposition technique for coating SRF cavities

ALD is a chemical vapor phase deposition technique that is distinguished by the key aspects:

* **Surface controlled (gas-solid surface reactions)**

* **Self-saturating**

* **Sequential**



Knoops et al., Handbook of Crystal Growth Vol III, 2nd ed. (2015)

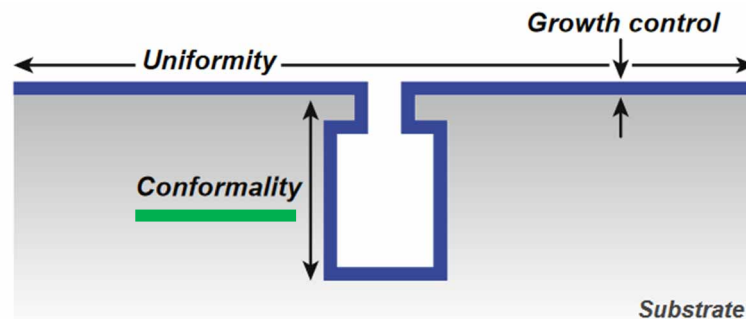
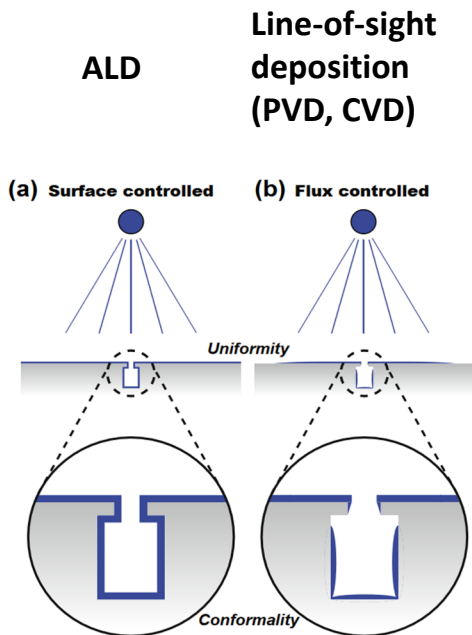
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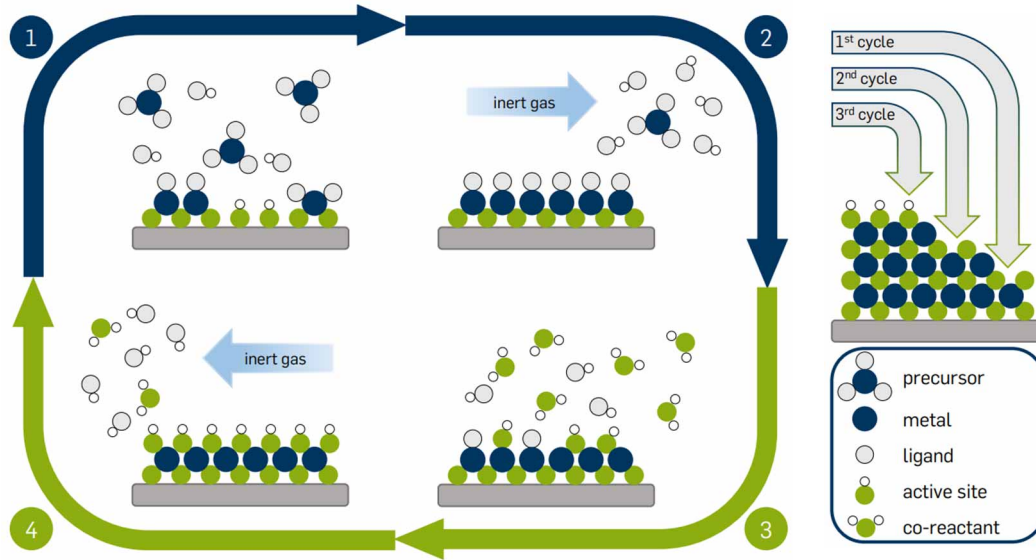
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Knoops et al., Handbook of Crystal Growth Vol III, 2nd ed. (2015)

How does ALD work? Thermal and plasma-enhanced ALD (PEALD)

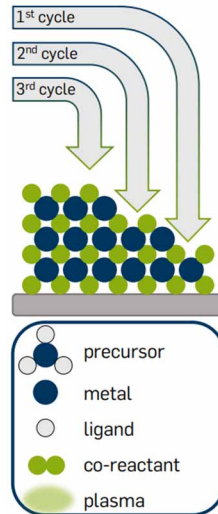
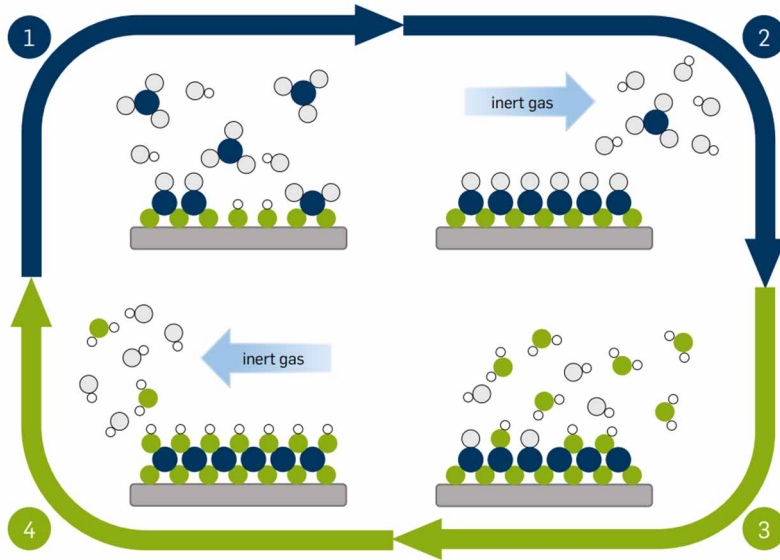
Thermal ALD



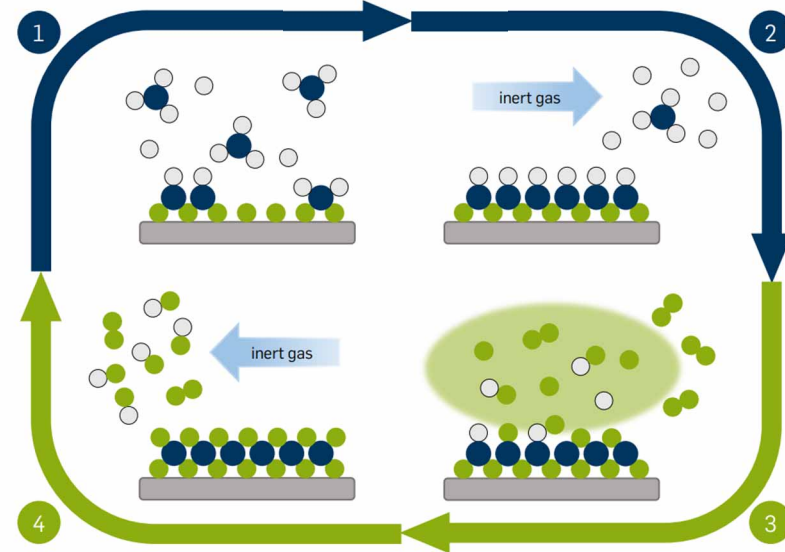
L. Mai, (2020), DOI:10.13154/294-7658.

How does ALD work? Thermal and plasma-enhanced ALD (PEALD)

Thermal ALD



PEALD



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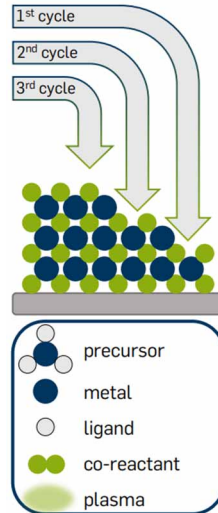
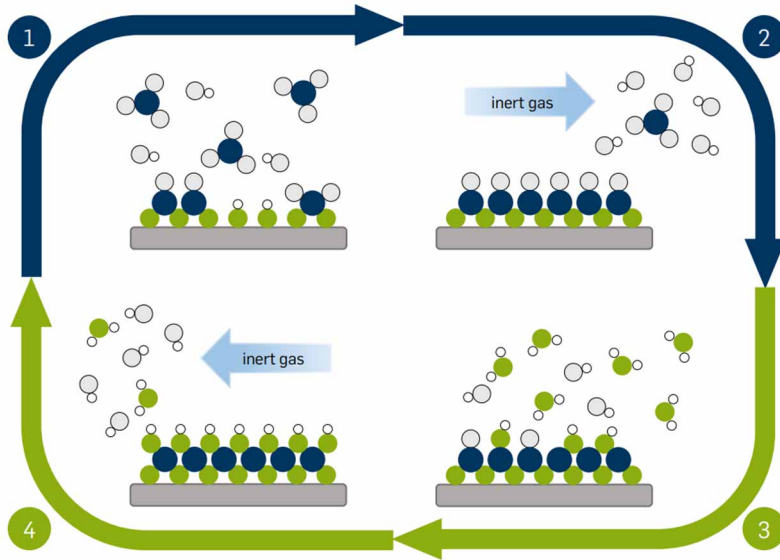
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Material candidates for SIS

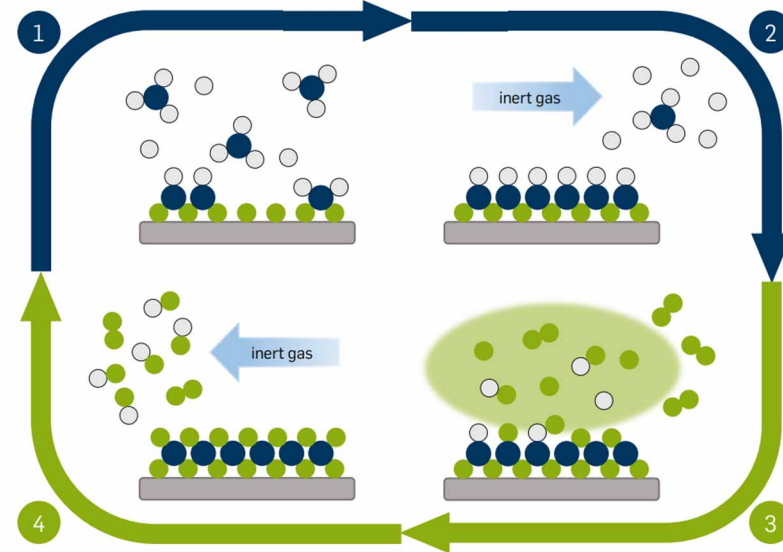
- S: NbN, NbTiN
- I: AlN, Al₂O₃

Deposition choice at UHH: Thermal ALD/PEALD

Thermal ALD



PEALD



L. Mai, (2020), DOI:10.13154/294-7658.

Thermal ALD: Al_2O_3

Capability for coating
single-cell cavities



PEALD: AlN, NbTiN, NbN

Capability for coating
planar samples



Thermal ALD: Al_2O_3

Capability for coating
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PEALD: AlN , NbTiN , NbN

Capability for coating
planar samples



Successful Al_2O_3 coating of high-gradient 1.3 GHz cavities by thermal ALD

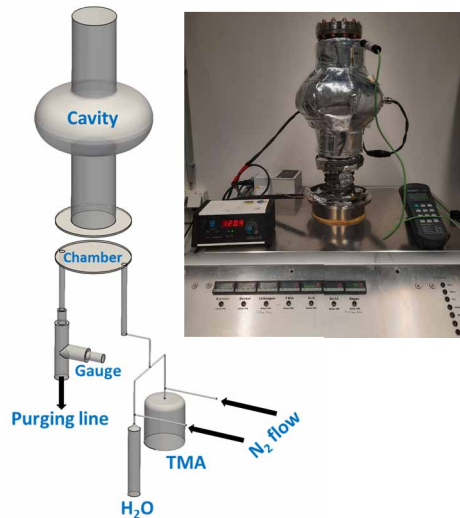
✓ Proof-of-principle experiment

- Process optimization
- Thermal ALD Process Simulation

✓ Several single-cell cavities successfully coated

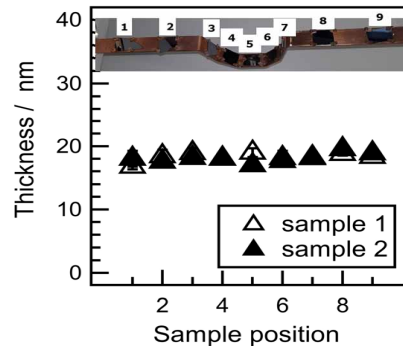
✓ Gradients above 40MV/m without any deterioration in Q-value

Thermal ALD setup

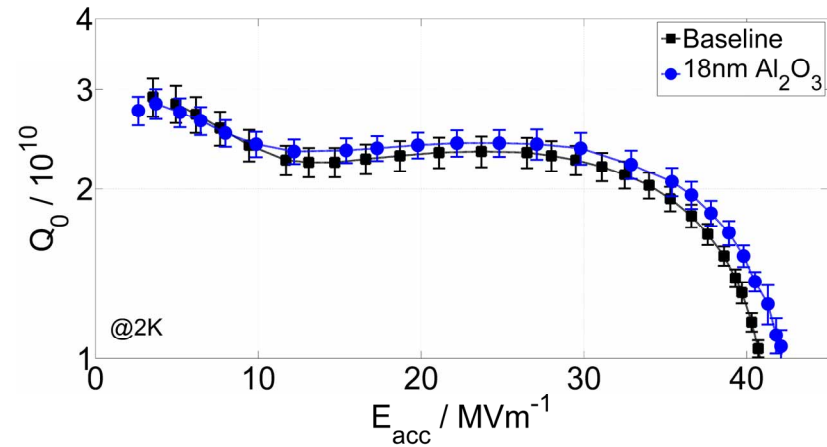


Process optimization

Precursors TMA/ H_2O
Temp. 120 °C
Thickness ~18 nm



Cavity performance



Marc Wenskat et al 2023 Supercond. Sci. Technol. 36 015010 DOI 10.1088/1361-6668/aca83f

For detailed information look at poster ID: **MOPMB016** (Getnet Kacha Deyu)

Thermal ALD: Al_2O_3

Capability for coating
single-cell cavities



PEALD: AlN , NbTiN , NbN

Capability for coating
planar samples



How we grow AlN-NbTiN multilayers by PEALD

DEPOSITION PARAMETERS

Temperature: 250 °C

Plasma power: 300 W

Base pressure: 1E-1 mbar



*GEMStar XT-P
from Arradance*



How we grow AlN-NbTiN multilayers by PEALD

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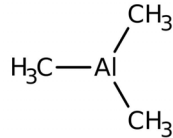
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Base pressure: 1E-1 mbar

Precursors: Al, Ti, and Nb

TMA: Trimethylaluminum



AlN

H_2/N_2 PLASMA

Plasma reactive species



GEMStar XT-P
from Arradance



How we grow AlN-NbTiN multilayers by PEALD

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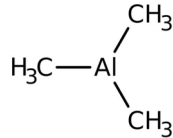
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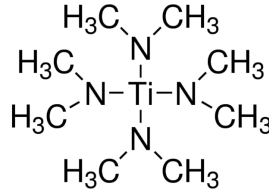
TMA: Trimethylaluminum



H_2/N_2 PLASMA
Plasma reactive species

= AlN

TDMAT: tetrakis(dimethylamino)titanium(IV)



= TiN



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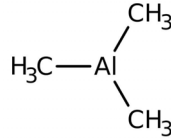
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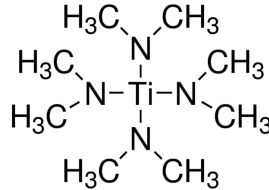
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Plasma reactive species

= AlN

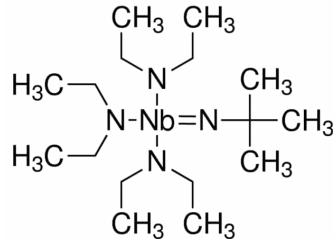
TDMAT: tetrakis(dimethylamino)titanium(IV)



= TiN

GEMStar XT-P
from Arradance

TBTDEN: (t-Butylimido)tris(diethylamino)niobium(V)



= NbN



How we grow AlN-NbTiN multilayers by PEALD

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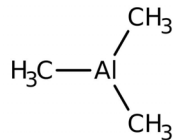
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+

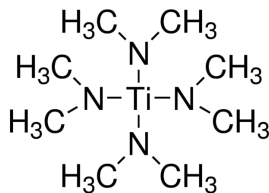
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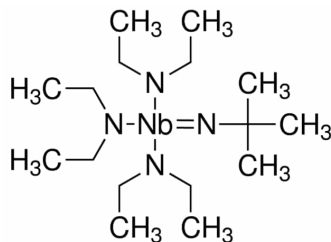


+



= TiN

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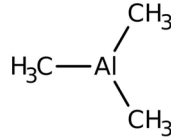
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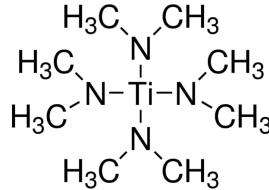


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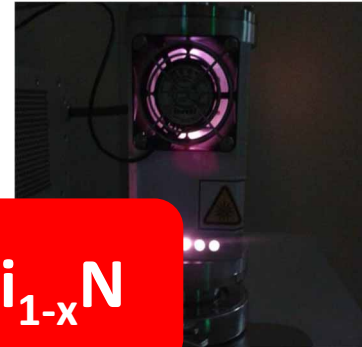
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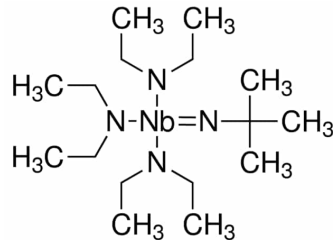


+



= TiN

TBTDEN: (t-Butylimido)tris(diethylamino)



+

= NbN

Nb_xTi_{1-x}N

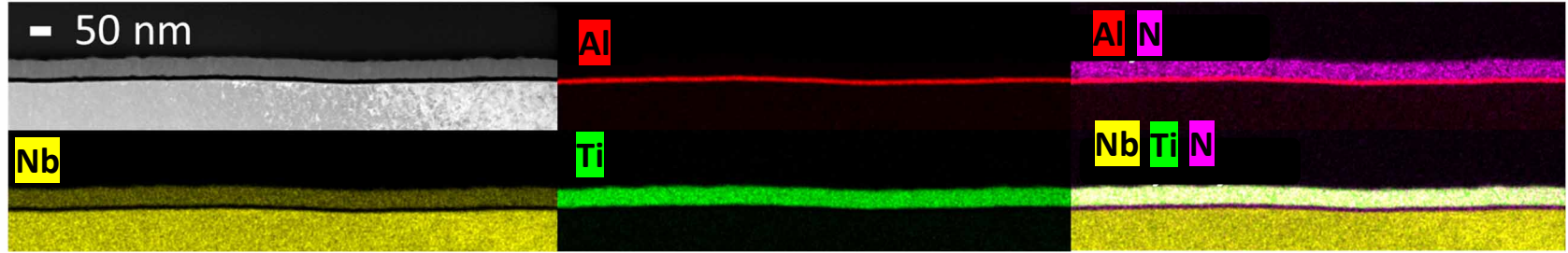


GEMStar XT-P
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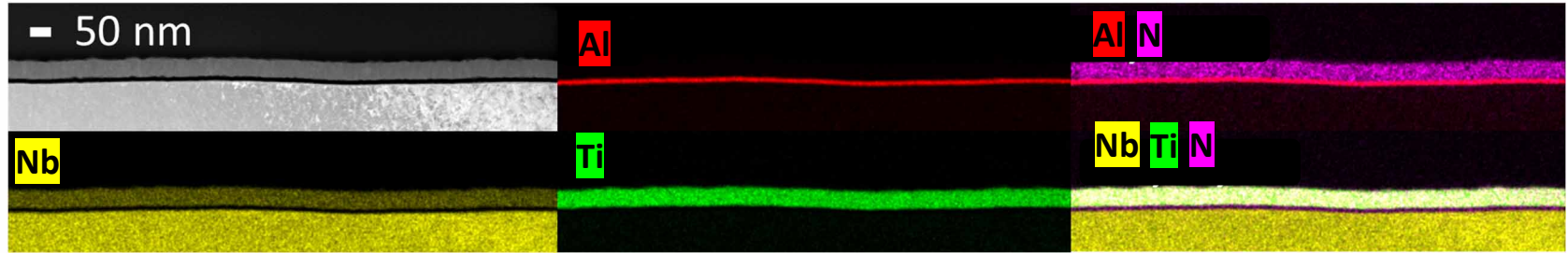
Tailored AlN-NbTiN multilayers deposited by PEALD on Nb and Si substrates

➤ Elemental analysis

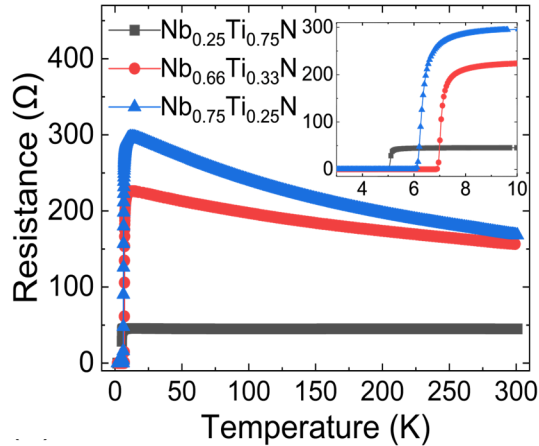


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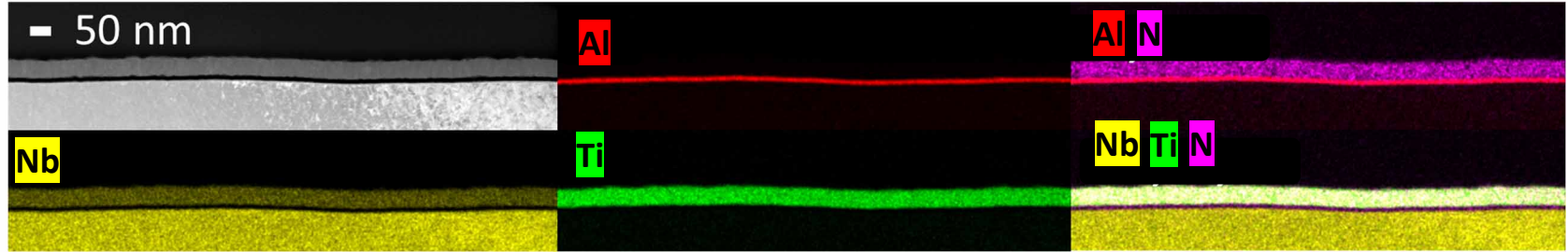


➤ Superconducting $Nb_xTi_{1-x}N$ film composition

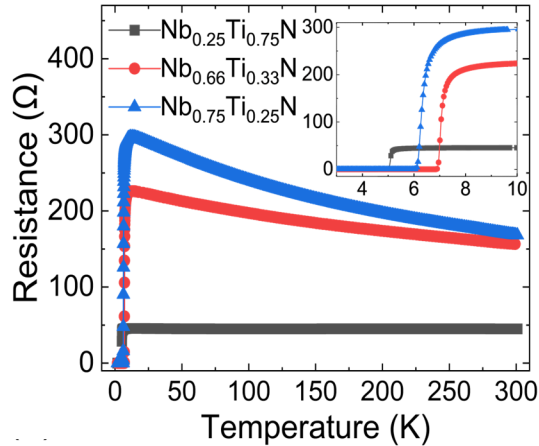


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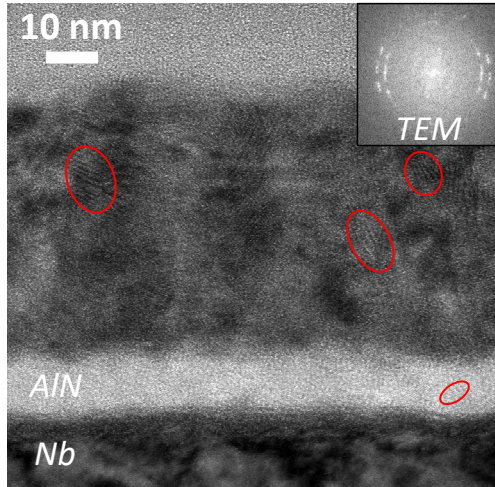
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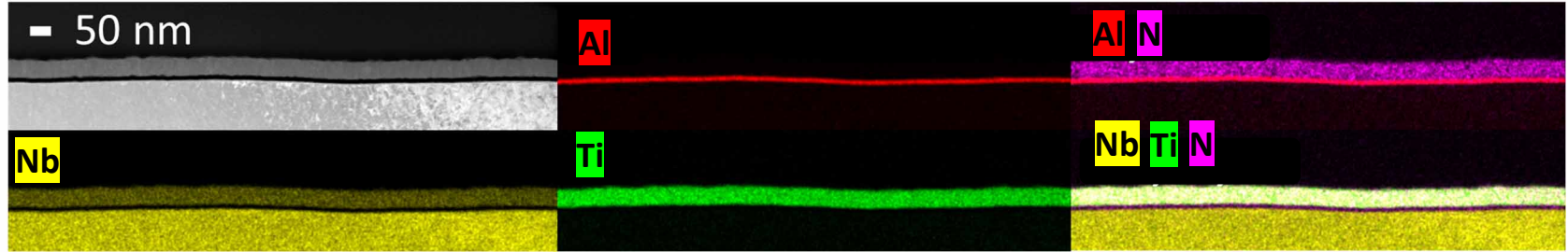


➤ Crystallinity

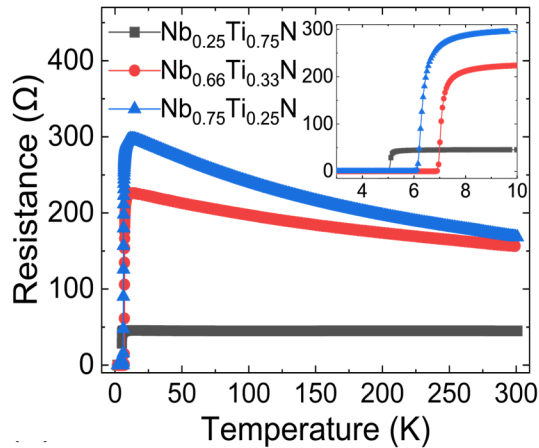


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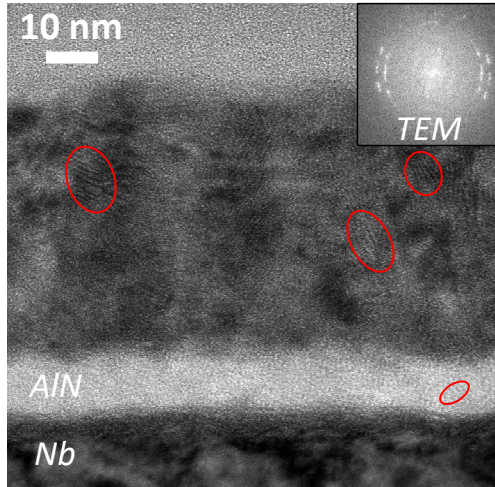
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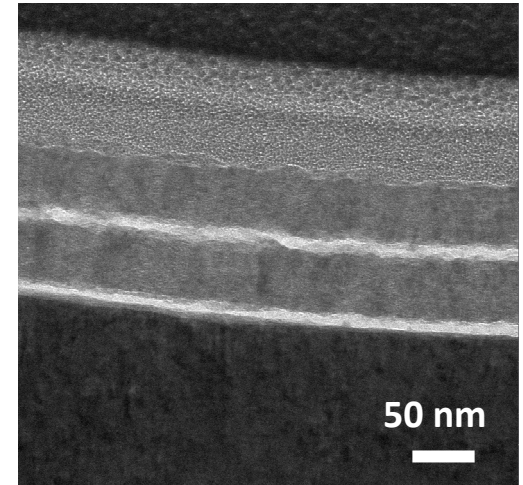
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➤ Crystallinity



➤ $Nb - (AlN - NbTiN) \times 2$

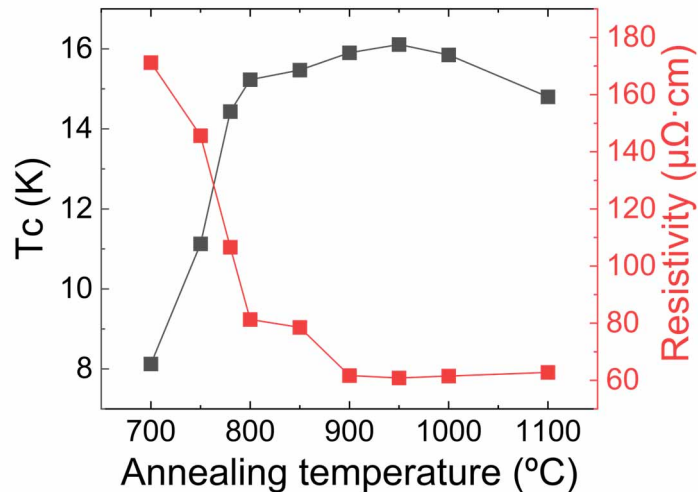


AlN-NbTiN multilayers by PEALD are ready to move on to cavities

➤ Enhancement superconducting properties annealing

AlN-NbTiN multilayers

Detailed info: I. González Díaz-Palacio et al., *Journal of Applied Physics*, submitted

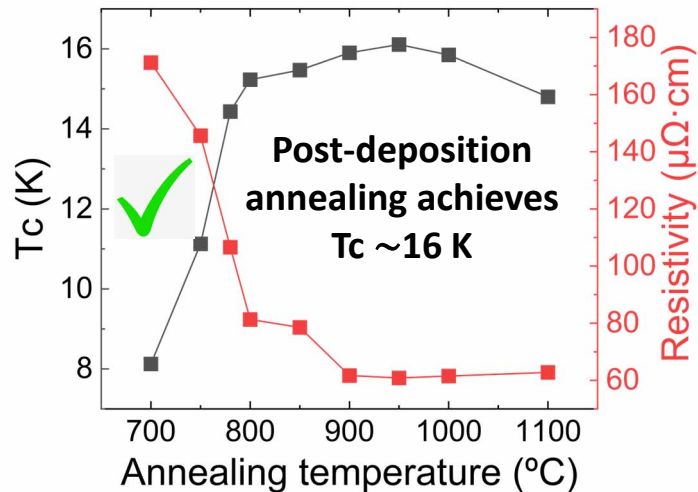


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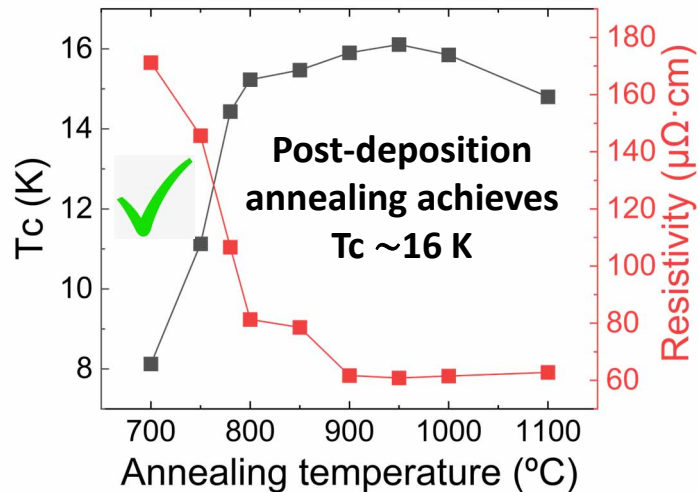
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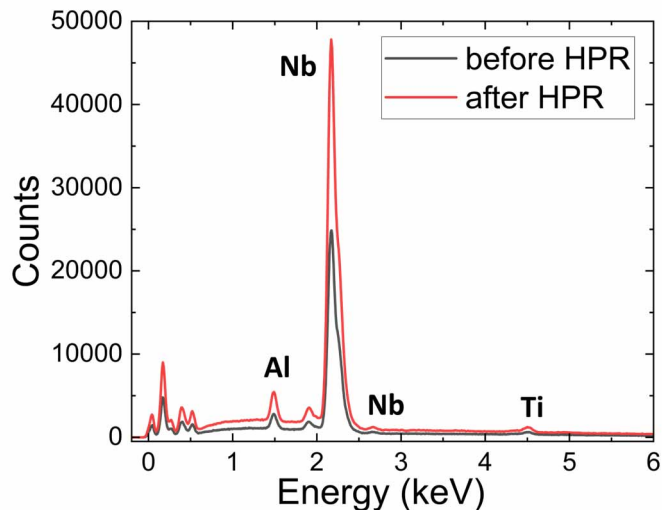
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- Success AlN-NbTiN multilayers to cavity preparation techniques: high pressure rinsing (HPR)



DESY facilities
Cleanroom ISO4

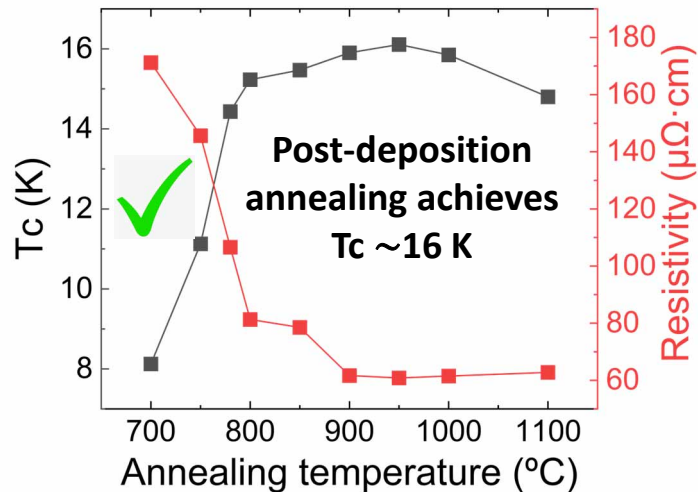


Layers deposited by (PE)-ALD survive 7 HPR

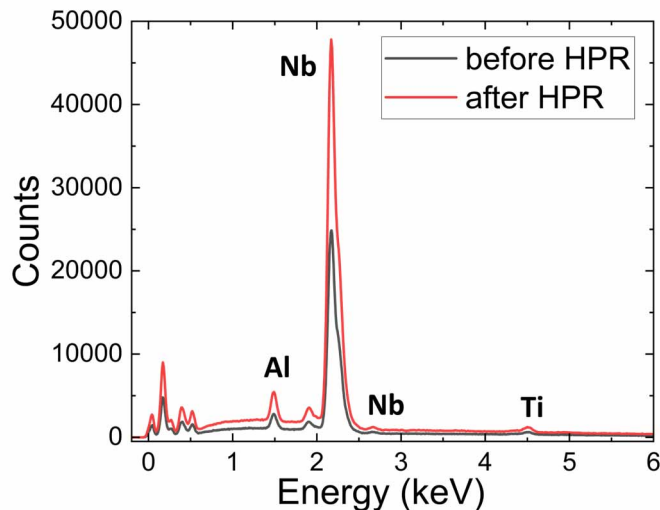
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- Success AlN-NbTiN multilayers to cavity preparation techniques: high pressure rinsing (HPR)



DESY facilities
Cleanroom ISO4

- Field emission from planar films threshold voltage of:



Annealed: 281 MV/m
As-deposited: 95 MV/m



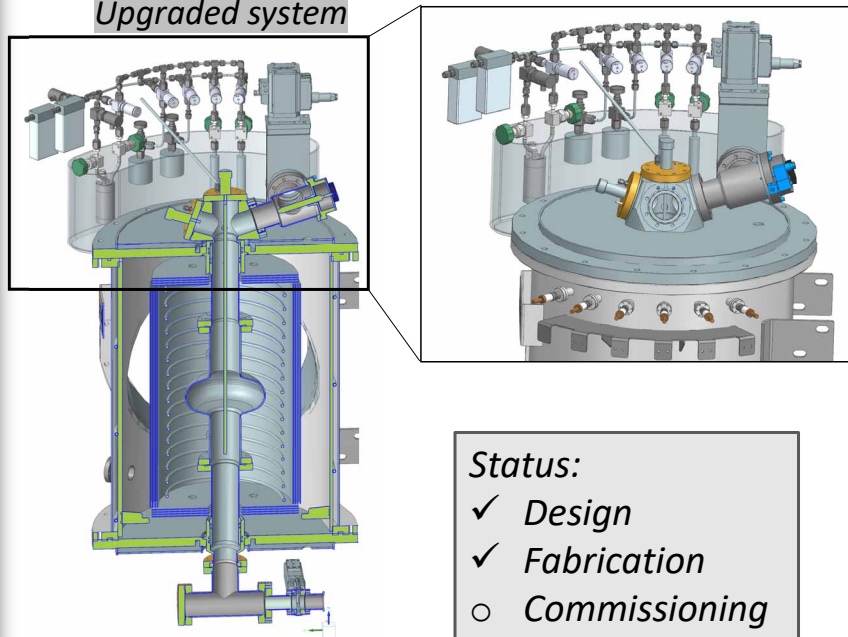
Layers deposited by (PE)-ALD
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PEALD AlN-NbTiN cavity coating on the next SRF 2025

For detailed information about the furnace look at poster ID: **WEPWB111** (Marc Wenskat)

EXTEND SINGLE-CELL FURNACE TO PEALD-SINGLE-CELL COATING SYSTEM

Upgraded system



High versatility in one system:

- PEALD and thermal ALD
- Capable depositing:
 - NbTiN / NbN
 - AlN
 - Al₂O₃
- In-situ annealing
 - dissolve oxide layers before coating
 - after coating

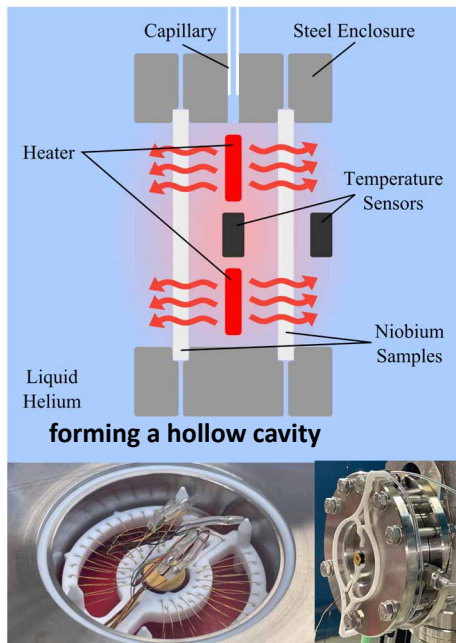
Status:

- ✓ Design
- ✓ Fabrication
- Commissioning



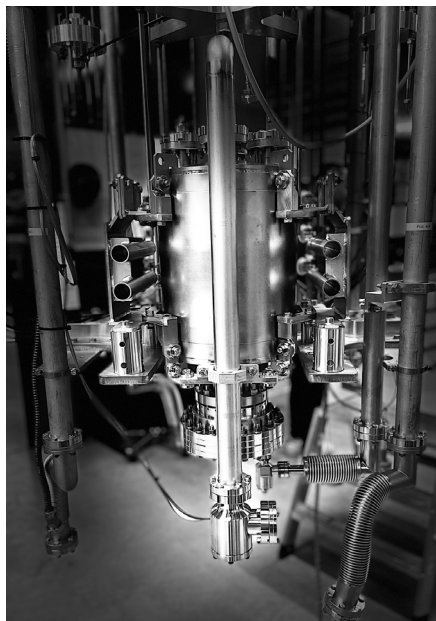
Related activities ongoing

- Thermal conductivity studies at UHH/DESY



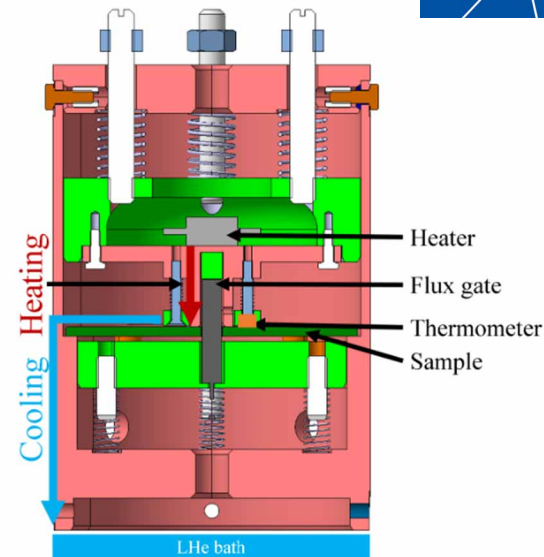
For detailed information look at poster ID: **MOPMB017** (Cem Saribal)

- Commissioning of the UHH Quadrupole Resonator (QPR) at DESY



For detailed information talk ID: **THCAA02** (Ricardo Monroy-Villa)

- Flux expulsion studies at CERN



For detailed information look at poster ID: **MOPMB003** (Daniel A. Turner)

- ✓ *Achieve coated cavities by thermal ALD and sustain high accelerating gradients without any performance deterioration*
- ✓ *SIS multilayers by PEALD and post-deposition annealing have been optimized on planar substrates – move on to cavities*
- ✓ *SRF2025 SIS coated cavity by PEALD: new setup under development*

Thanks to:

SRF R&D group DESY/UHH: *Wolfgang Hillert, Hans Weise, Detlef Reschke, Marc Wenskat, Getnet Kacha Deyu, Cornelius Martens, Lea Steder, Rezvan Ghanbari, Lea Preece, Cem Saribal, Nicolay Krupka, Christopher Bate, Ricardo Monroy-Villa, Jonas Wolf, Mateusz Wiencek, and many more.* **ALD group UHH (CHyN):** *Robert Blick, Robert Zierold, Jun Peng, Carina Hedrich, Stefanie Haugg, Kristian Deneke, Malte Siegmung and more.* **Collaborators:** *Dirk Lützenkirchen-Hecht (U. Wuppertal), Frederic Braun (U. Wuppertal), Alick Macpherson (CERN), Daniel Turner (CERN), Tobias Junginger (U. Victoria) and more.* **Organizing Committee**

Thank you for your attention

Please, feel free to contact via: igonzale@physnet.uni-hamburg.de